



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
4001/	160mΩ @ V _{GS} = 10V	2.6A
100V	200mΩ @ V _{GS} = 4.5V	2.3A

Description

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

- Power Management Functions
- Battery Operated Systems and Solid-State Relays
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.

Features and Benefits

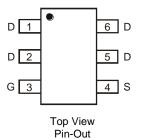
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

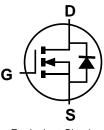
Mechanical Data

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.015 grams (Approximate)



Top View





Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMN10H170SVT-7	TSOT26	3,000/Tape & Reel
DMN10H170SVT-13	TSOT26	10,000/Tape & Reel

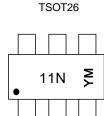
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



 $\begin{array}{l} 11N = \mbox{Product Type Marking Code} \\ YM = \mbox{Date Code Marking} \\ Y \mbox{ or } \overline{Y} = \mbox{Year (ex: B = 2014)} \\ M = \mbox{Month (ex: 9 = September)} \end{array}$

Date Code Rey												
Year	2014		2015	2016		2017	2018		2019	2020		2021
Code	В		С	D		E	F		G	Н		
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Drain-Source Voltage	V _{DSS}	100	V
Gate-Source Voltage	V _{GSS}	±20	V
Continuous Drain Current (Note 6) V_{GS} = 10V	Ι _D	2.6 2.1	А
Pulsed Drain Current (10µs pulse, duty cycle ≦1%)	I _{DM}	11.2	А
Maximum Body Diode Continuous Current (Note 6)	Is	2.0	А

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Total Dowar Dissinction	(Note 5)	D	1.2	W	
Total Power Dissipation	(Note 6)	PD	1.7		
Thermal Desistance Junction to Ambient	(Note 5)		101		
Thermal Resistance, Junction to Ambient	(Note 6)	R _{0JA}	73	°C/W	
Thermal Resistance, Junction to Case	R _{θJC}	15			
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C		

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						·
Drain-Source Breakdown Voltage	BV _{DSS}	100			V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	IDSS	_	_	1.0	μA	$V_{DS} = 100V, V_{GS} = 0V$
Gate-Body Leakage	I _{GSS}			±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						·
Gate Threshold Voltage	V _{GS(th)}	1.0	2.0	3.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	D	_	115	160	mΩ	$V_{GS} = 10V, I_D = 5.0A$
Static Drain-Source On-Resistance	R _{DS (ON)}	_	124	200	1112	$V_{GS} = 4.5V, I_D = 5.0A$
Diode Forward Voltage	V _{SD}	_	0.9	1.0	V	$V_{GS} = 0V, I_{S} = 10A$
DYNAMIC CHARACTERISTICS (Note 8)						·
Input Capacitance	Ciss		1,167			$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz
Output Capacitance	Coss	_	36		pF	
Reverse Transfer Capacitance	C _{rss}	_	25	_		
Gate Resistance	Rg	_	1.3		Ω	VDS = 0V, VGS = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 4.5V)	Qg		4.9			
Total Gate Charge (V _{GS} = 10V)	Qg		9.7			
Gate-Source Charge	Q _{gs}		2.0		nC	$V_{DS} = 80V, I_D = 12.8A$
Gate-Drain Charge	Q _{gd}	_	2.0			
Turn-On Delay Time	t _{D(on)}	_	10			
Turn-On Rise Time	tr		11			$V_{DD} = 50V, V_{GS} = 10V,$
Turn-Off Delay Time	t _{D(off)}		42		nS	$R_{\rm G} = 25\Omega, I_{\rm D} = 12.8A$
Turn-Off Fall Time	t _f		12			
Reverse Recovery Time	trr		30		nS	
Reverse Recovery Charge	Qrr		35		nC	V _{GS} = 0V, I _S =12.8A, di/dt=100A/µs

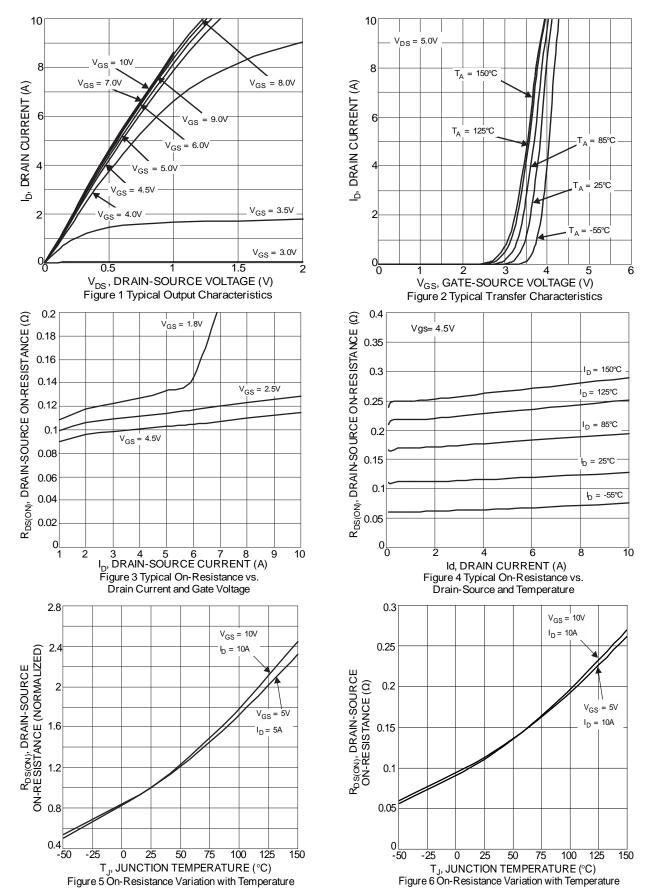
 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate. Notes:

7. Short duration pulse test used to minimize self-heating effect.

8. Guaranteed by design. Not subject to product testing.



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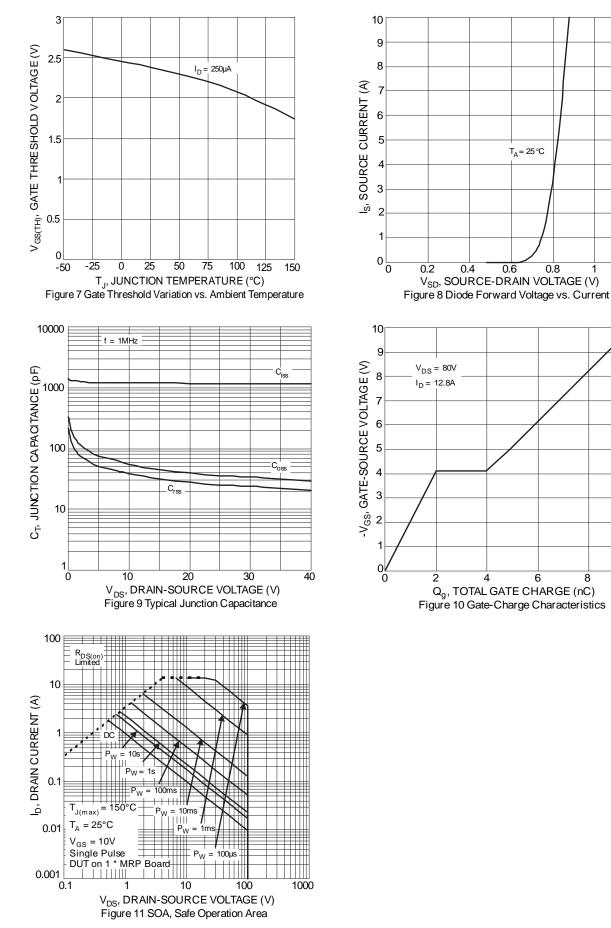




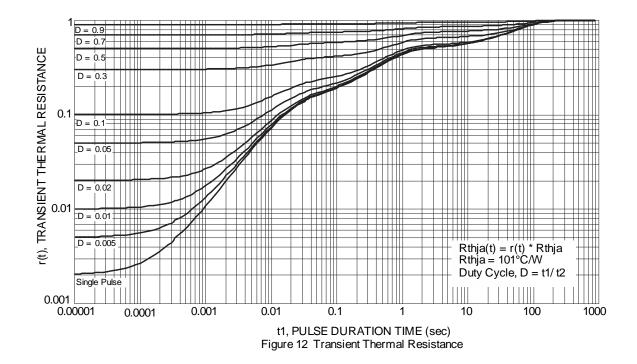
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1.2

10

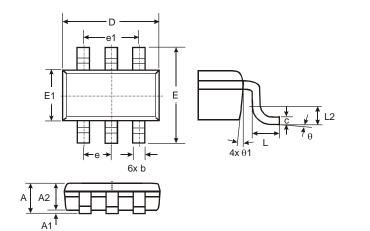






Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

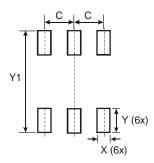


TSOT26							
Dim	Min	Max	Тур				
Α	-	1.00	-				
A1	0.01	0.10	-				
A2	0.84	0.90	-				
D	-	-	2.90				
ш	-	-	2.80				
E1	-	-	1.60				
b	0.30	0.45	-				
С	0.12	0.20	-				
e	-	-	0.95				
e1	-	-	1.90				
L	0.30	0.50					
L2	-	-	0.25				
θ	0°	8°	4°				
θ1	4°	12°	-				
All D	imensi	ons in	mm				



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199

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